EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	0	(retest$3 with ((cell) adj select$3)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 08:49
L3	0	(retest$3 adj ((cell))) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 08:49
L4	4	(reselect$3 adj ((cell))) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 08:50
L5	0	(select$3 adj another adj (spare adj cell)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 08:51
L6	0	(another adj (spare adj cell)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 08:51
L7	0	(different adj (spare adj cell)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 08:51
L8	13	(different with (spare adj cell)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 08:51
L9	0	(another with (spare adj cell)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 08:51
S65	1755	714/25.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:45

S66	674	714/42.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/05 13:31
S67	280	714/54.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/05 14:47
S70	39	714/42.ccls. and bist	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:56
S71	27	("5255227" | "5848077" | "5896331" | "5956350" | "6000047" | "6085334" | "6141779" | "6304989" | "6408401" | "6421794" | "6425095" | "6438046" | "6446224" | "6496947" | "6505308" | "6505313" | "6535993" | "6560740" | "6640321").PN. OR ("6691252").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/06/05 13:43
S72	24	("20020108073" | "4460997" | "4701887" | "5337318" | "5355340" | "5469389" | "5506807" | "5621691" | "5831915" | "5896328" | "5999450" | "6115300" | "6134142" | "6327197" | "6366508" | "6373758" | "6408401" | "6426902" | "6445626" | "6477662" | "6496947" | "6571348" | "6691252" | "6795942").PN. OR ("6928377").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/06/05 13:45
S73	8	("5541942" | "5758056" | "5764878" | "6035432" | "6385746" | "6449704").PN. OR ("6640321").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/06/05 14:35
S74	637	714/7.ccls.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/06/05 14:35
S75	14	714/42.ccls. and (built adj in adj self adj test$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:56

S85	25	S74 and (bist (built adj in adj self adj test$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:58
S86	6	S67 and (bist (built adj in adj self adj test$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:57
S87	28	S74 and (bist (built adj in adj self adj test$3) (built-in adj self-test$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/05 15:21
S88	3	S87 not S85	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/05 15:18
S89	20	714/711.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:58
S90	34	714/710.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:59
S91	252	714/718.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 16:03
S92	27	714/42.ccls. and ((built adj in adj self adj test$3) (built-in adj self-test$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/05 15:22
S93	13	S92 not S75	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/05 15:22

S94	15	("4325120" | "4701919" | "5555212" | "5579484" | "5724365" | "5771195" | "5808948" | "5920515" | "6065134" | "6175936" | "6199031" | "6516430" | "6516450").PN. OR ("6728910").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/06/05 16:43
S95	1	10/750961	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/11 17:50
S96	2072	(memory adj test$3) and pin	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/11 17:51
S97	93	(memory adj test$3) and (pin with (fail))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/11 17:51
S98	7	(US-20020120887-$).did. or (US-6065134-$ or US-6728910-$ or US-6085334-$ or US-6928588-$ or US-6640321-$ or US-6181614-$).did.	US-PGPUB; USPAT	OR	OFF	2006/06/11 17:54
S99	0	S98 and manifactur$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/11 17:54
S100	6	S98 and manufactur$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/11 17:59
S101	0	S98 and post	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/11 17:59
S102	122	(memory adj test$3) with post	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/11 18:04

S103	45	(memory adj test$3) and (register with (redundant) with (row column))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/06/11 18:05
S104	51	714/25.ccls. and @pd>"20060530"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/03/31 19:04
S105	1	714/42.ccls. and bist and @pd>"20060418"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/03/31 19:03
S106	1	714/42.ccls. and (built adj in adj self adj test$3) and @pd>"20060418"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:57
S107	284	714/54.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:57
S108	0	S107 and (bist (built adj in adj self adj test$3)) and @pd>"20040930"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:57
S109	657	714/7.ccls.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/09/09 15:58
S110	0	S109 and (bist (built adj in adj self adj test$3)) and @pd>"20060516"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/09/09 15:58
S111	1	714/711.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060221"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/07 06:22
S112	4	714/710.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060516"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/07 06:32
S113	17	714/718.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060523"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/07 06:35

S114	35	714/718.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060907"	US-PGPUB, USPAT; EPO; JPO, DERWENT; IBM_TDB	OR	OFF	2007/03/31 19:00
S115	7	714/710.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060815"	US-PGPUB, USPAT; EPO; JPO, DERWENT; IBM_TDB	OR	OFF	2007/03/31 19:03
S116	6	714/42.ccls. and bist and @pd>"20060704"	US-PGPUB; USPAT; EPO; JPO, DERWENT; IBM_TDB	OR	OFF	2007/03/31 19:03
S117	5	714/711.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060815"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/03/31 19:04
S118	104	714/25.ccls. and @pd>"20060907"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/07 08:01
S119	9	714/711.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060815"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/07 06:22
S120	14	714/710.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060815"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/07 06:32
S121	82	714/718.ccls. and (bist (built adj in adj self adj test $3) (built-in adj self-test $3)) and @pd>"20060907"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/09/07 06:35
S122	78	714/25.ccls. and @pd>"20070329"	US-PGPUB; USPAT; EPO; JPO, DERWENT; IBM_TDB	OR	OFF	2007/09/07 08:01

S123	21	("4325120" | "4701919" | "5555212" | "5579484" | "5724365" | "5771195" | "5808948" | "5920515" | "6065134" | "6175936" | "6199031" | "6516430" | "6516450").PN. OR ("6728910").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/04/15 10:25
S124	7	("20030072204" | "20030117886" | "20040109371" | "6288940" | "6295237" | "6438044" | "6728910").PN. OR ("7352638").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/04/15 10:28
S125	1	("2004/0109371").URPN.	USPAT	OR	OFF	2008/04/15 10:28
S126	13	("20040117694" | "20040205427" | "20040237009" | "6052798" | "6065134" | "6246618" | "6366508" | "6374370" | "6462995" | "6507524" | "6667918" | "6728910" | "6928591").PN. OR ("7257733").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/04/15 10:47
S127	2	("2004/0237009").URPN.	USPAT	OR	OFF	2008/04/15 10:55
S128	5	("20030101389" | "4751656" | "6026505" | "6795942").PN. OR ("6928591").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/04/15 11:11
S129	38	("4757503" | "5153880" | "5243570" | "5267205" | "5267242" | "5325333" | "5337277" | "5377146" | "5424986" | "5487040" | "5553231" | "5684740" | "5764878" | "5805789").PN. OR ("6065134").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/04/15 12:07
S130	1	10/750961	US-PGPUB; USPAT; USOCR	OR	OFF	2008/04/15 12:24
S134	4	("6181614" | "6643195" | "6728910" | "6801471").PN. OR ("7062695").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/04/15 15:00

S135	2	"5327382".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/04/16 11:29
S136	2	"6144592".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/04/16 13:03
S137	2	"20040261049"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/04/16 13:05
S138	20	(testing adj (spare adj memory))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/04 10:00
S139	5	(checking adj (spare adj memory))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/04 10:03
S140	5	(checking adj (redundant adj memory))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/04 10:07
S141	87	(testing adj (redundant adj memory))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/04 10:08
S142	694	(test$3 with memory) with (spare)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 00:56
S143	241	(test$3 with semiconductor) with (spare)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 00:56
S144	332	cache with spare	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:01

S145	14	(test$3 adj spare) with (semiconductor)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:03
S146	0	(test$3 adj cell adj before adj use)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:15
S147	0	(test$3 adj cell adj before adj using)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:15
S148	0	(test$3 adj cell adj before adj store)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:16
S149	0	(test$3 adj cell adj before adj storing)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:16
S150	0	(test$3 adj cell adj prior adj use)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:16
S151	30	(test$3 adj cell adj prior)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:16
S152	6	(test$3 with (cell adj prior)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:17
S153	0	(test$3 adj (cell adj prior)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:20
S154	0	(test$3 adj (spare adj cell adj prior)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:20

S155	0	(check$3 adj (spare adj cell adj prior)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:20
S156	0	((spare adj cell adj prior)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:20
S157	0	((spare adj prior)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:20
S158	2	("5652725").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:21
S159	0	repeat$3 with ((redundant spare) adj (row column) adj test$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:30
S160	13	repeat$3 with ((redundant spare) adj test$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:30
S161	4	repeat$3 with ((redundant spare) adj select$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:31
S162	280	repeat$3 with ((cell) adj select$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:32
S163	57	(repeat$3 with ((cell) adj select$3)) and (semiconductor adj memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/06/08 01:32

6/8/08 9:40:48 AM

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